Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/552,811	BAIER ET AL.
Examiner	Art Unit
Hana A. Sanei	2879

SEARCHED				
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Class	Subclass	Date	Examiner	
Updated	Previous Search	3/2/2007	HAS	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
				

SEARCH NOT (INCLUDING SEARCH	'ES STRATEGY)
	DATE	EXMR
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